

# Device Modeling Report

COMPONENTS:THYRISTOR  
PART NUMBER:03P6MG  
MANUFACTURER: NEC



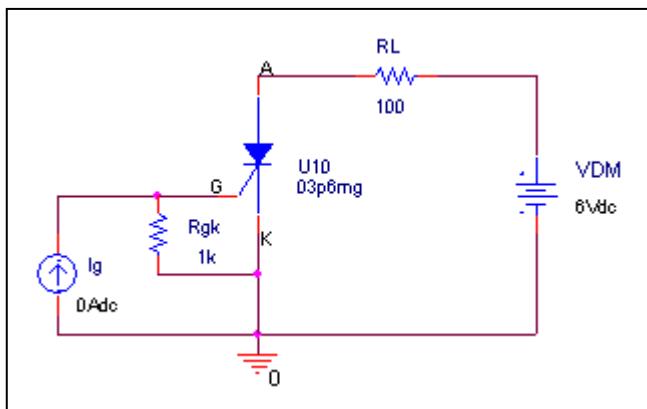
**Bee Technologies Inc.**

## DIODE MODEL

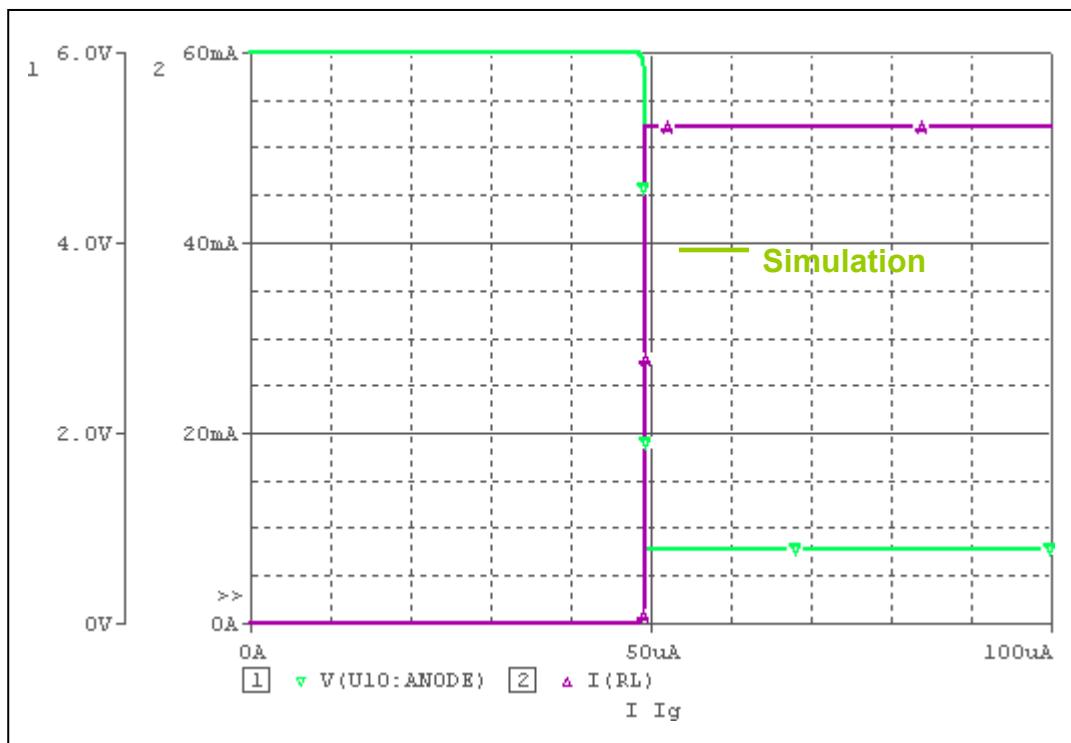
Pspice model Parameter	Model description
IS	Saturation Current
N	Emission Coefficient
RS	Series Resistance
IKF	High-injection Knee Current
CJO	Zero-bias Junction Capacitance
M	Junction Grading Coefficient
VJ	Junction Potential
ISR	Recombination Current Saturation Value
BV	Reverse Breakdown Voltage(a positive value)
IBV	Reverse Breakdown Current(a positive value)
TT	Transit Time

## IG-VT Characteristic

Evaluation Circuit



Simulation result

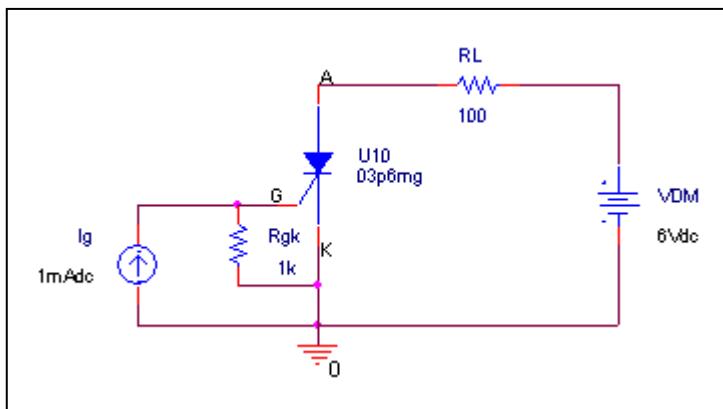


Comparison Table

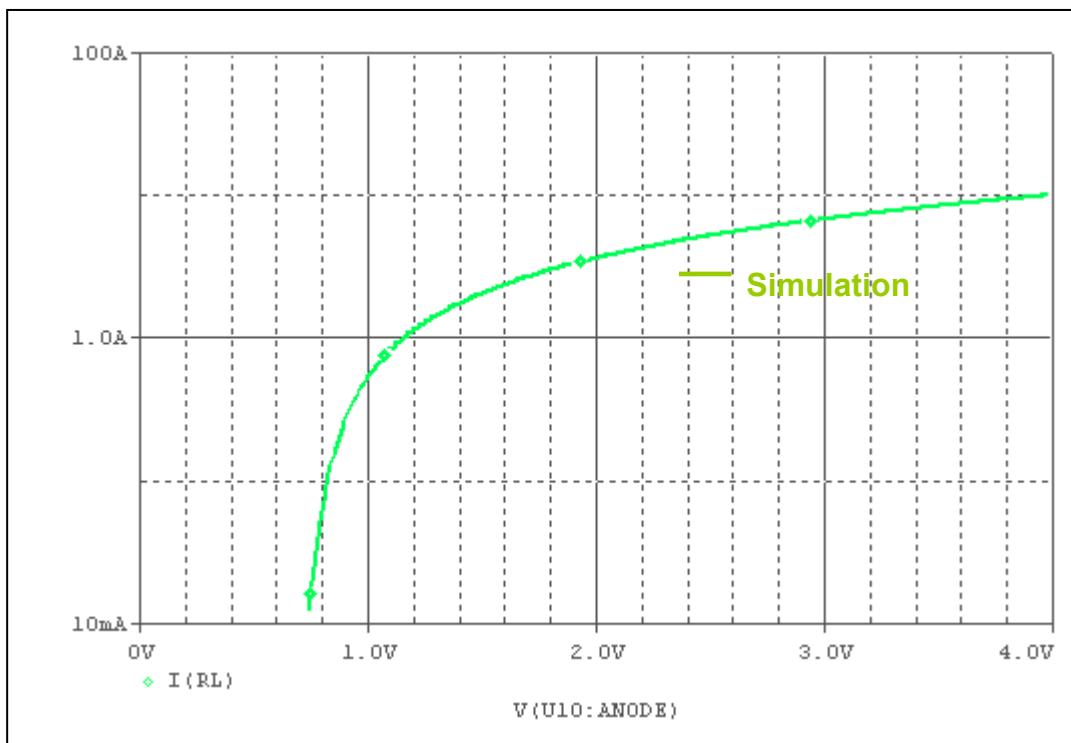
	Measurement	Simulation	% Error
$I_{G_T}$ ( $\mu$ A)	50(max)	48.691	2.6180
$V_{G_T}$ (V)	0.8(max)	0.788856	1.3930

## ITM-VTM Characteristic

Evaluation Circuit



Simulation result

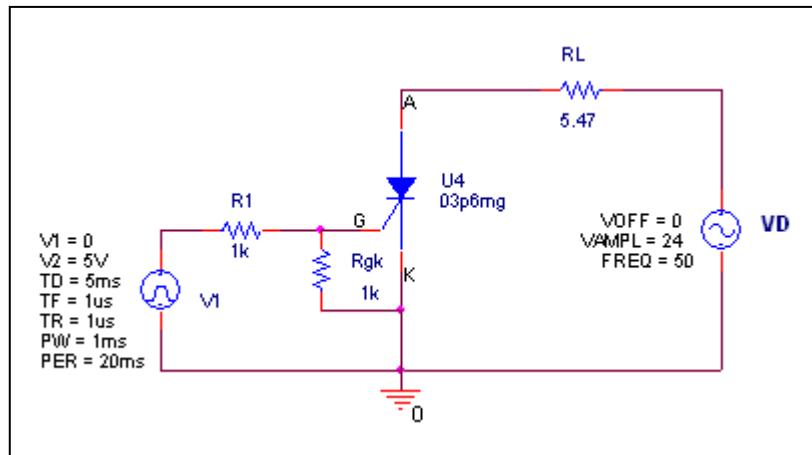


Comparison Table

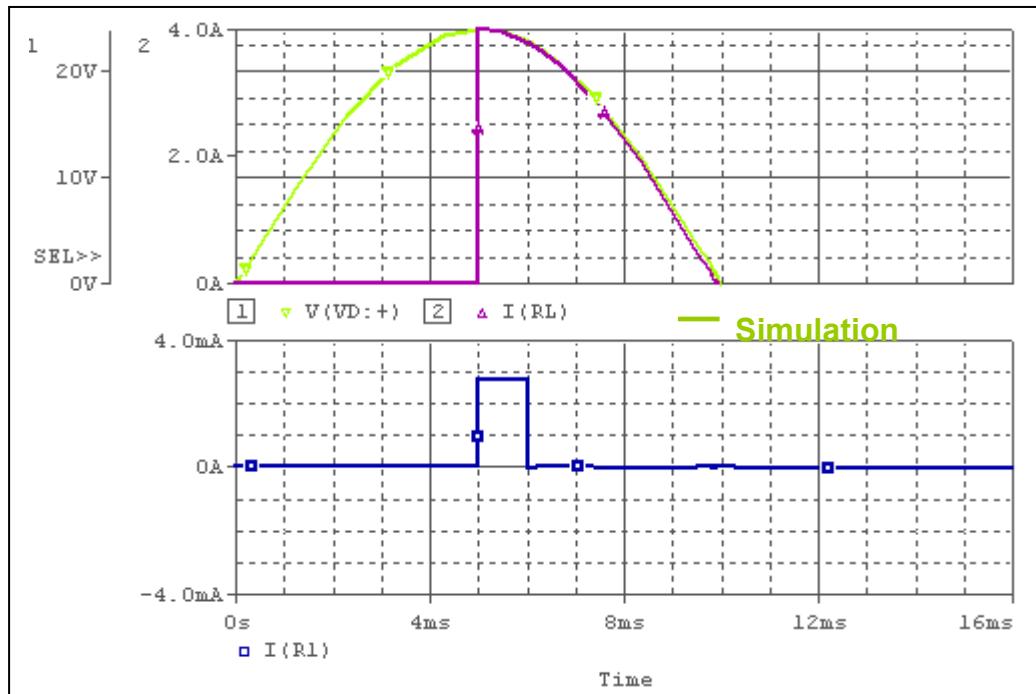
At ITM=4A	Measurement	Simulation	% Error
VTM(V)	2.2(max)	2.1172	3.7636

## Holding Characteristic (IH)

Evaluation Circuit



Simulation result

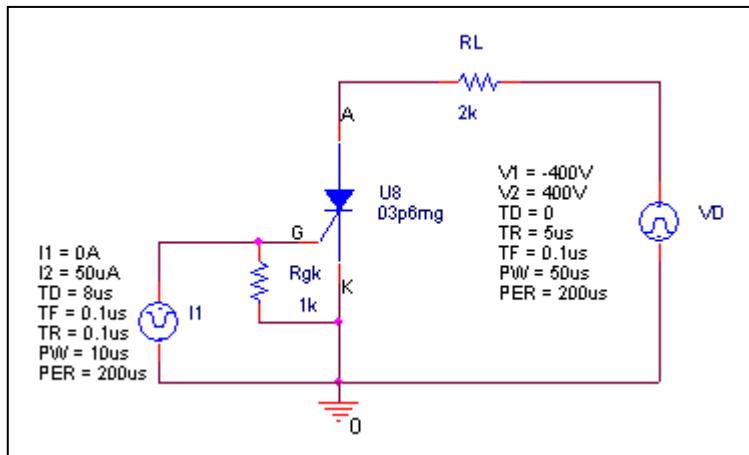


Comparison Table

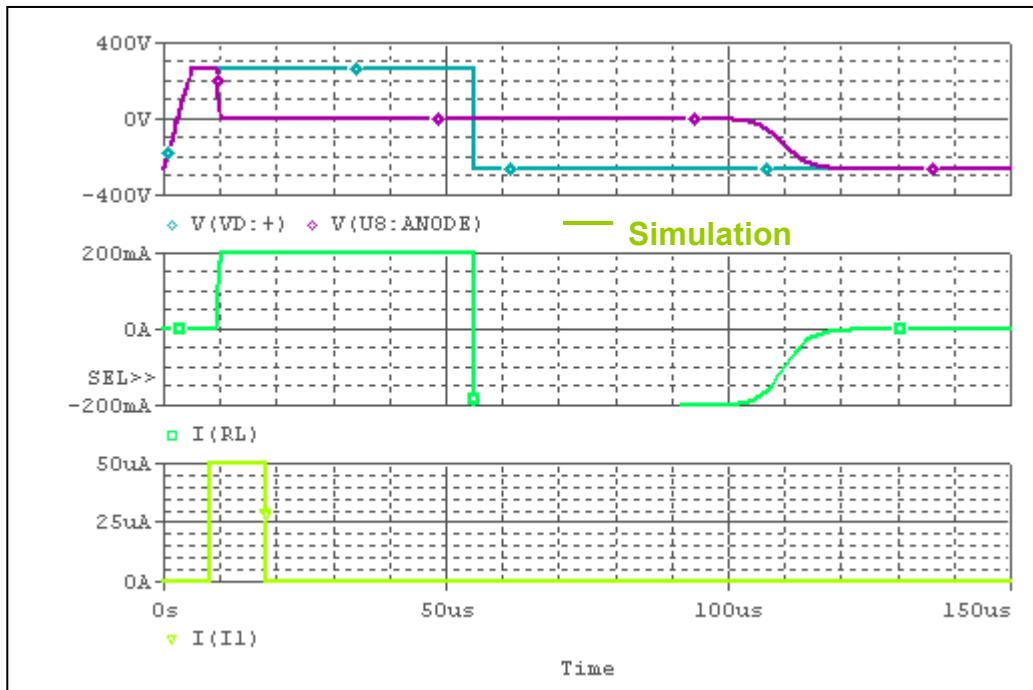
$V_{DM}=24V, I_{TM}=4A$	Measurement	Simulation	% Error
IH(mA)	5(max)	3.3024	0

## Switching Time Characteristic

Evaluation Circuit



Simulation result



Comparison Table

	Measurement	Simulation	%Error
Toff(us)	60	59.765	0.3917